

# HCT80R850

## 800V N-Channel Super Junction MOSFET

### Features

- Very Low FOM ( $R_{DS(on)} \times Q_g$ )
- Extremely low switching loss
- Excellent stability and uniformity
- 100% Avalanche Tested
- Built-in ESD Diode

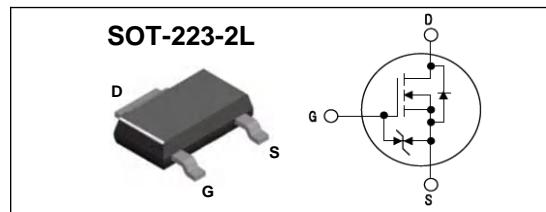
### Key Parameters

Parameter	Value	Unit
$BV_{DSS} @ T_{j,max}$	850	V
$I_D$	6.6	A
$R_{DS(on)}, \text{max}$	0.85	$\Omega$
$Q_{g,Typ}$	13.7	nC

### Application

- Switch Mode Power Supply (SMPS)
- TV power & LED Lighting Power
- AC to DC Converters
- Telecom

### Package & Internal Circuit



### Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Value	Unit
$V_{DSS}$	Drain-Source Voltage	800	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ )	6.6 *	A
	Drain Current - Continuous ( $T_C = 100^\circ\text{C}$ )	4.2 *	A
$I_{DM}^1)$	Drain Current - Pulsed	19.8 *	A
$E_{AS}^2)$	Single Pulsed Avalanche Energy	84	mJ
$I_{AR}$	Avalanche Current	1.4	A
$dv/dt$	MOSFET $dv/dt$ ruggedness, $V_{DS}=0\dots 400\text{V}$	50	V/ns
$dv/dt$	Reverse diode $dv/dt$ , $V_{DS}=0\dots 400\text{V}$ , $I_{DS} \leq I_D$	15	V/ns
$P_D$	Power Dissipation ( $T_C = 25^\circ\text{C}$ )	6.9	W
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$

\* Drain current limited by maximum junction temperature

### Thermal Resistance Characteristics

Symbol	Parameter	Value	Unit
$R_{\theta JS}$	Thermal Resistance, Junction-to-Solder point, Max.	18.1	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient , Max.	60	$^\circ\text{C/W}$

**Electrical Characteristics**  $T_J=25^\circ\text{C}$  unless otherwise specified

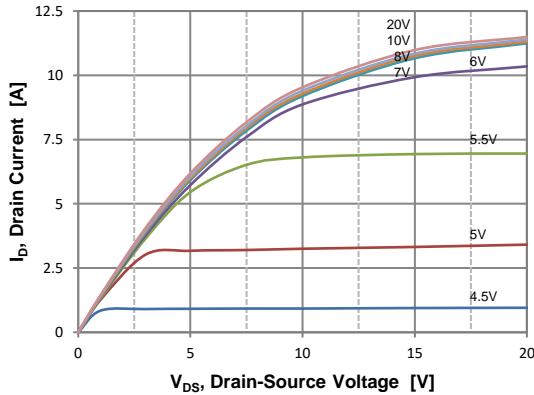
Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
<b>On Characteristics</b>						
$V_{GS}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 220 \mu\text{A}$	2.0	-	4.0	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}$ , $I_D = 1.6 \text{ A}$	-	0.74	0.85	$\Omega$
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}$ , $I_D = 1\text{mA}$	800	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 800 \text{ V}$ , $V_{GS} = 0$	-	-	1	$\mu\text{A}$
		$V_{DS} = 800 \text{ V}$ , $T_C = 150^\circ\text{C}$	-	-	100	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 20 \text{ V}$ , $V_{DS} = 0 \text{ V}$	-	-	$\pm 1$	$\mu\text{A}$
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS} = 500 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1.0 \text{ MHz}$	-	635	-	pF
$C_{oss}$	Output Capacitance		-	14.6	-	pF
$C_{rss}$	Reverse Transfer Capacitance		-	2.5	-	pF
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Time	$V_{DS} = 400 \text{ V}$ , $I_D = 2.8 \text{ A}$ , $R_G = 25 \Omega$ (Note 3,4)	-	23	-	ns
$t_r$	Turn-On Rise Time		-	18	-	ns
$t_{d(off)}$	Turn-Off Delay Time		-	74	-	ns
$t_f$	Turn-Off Fall Time		-	17	-	ns
$Q_{g()}$	Total Gate Charge	$V_{DS} = 640 \text{ V}$ , $I_D = 2.8 \text{ A}$ , $V_{GS} = 10 \text{ V}$ (Note 3,4)	-	13.7	-	nC
$Q_{gs}$	Gate-Source Charge		-	2.9	-	nC
$Q_{gd}$	Gate-Drain Charge		-	4.2	-	nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_S$	Maximum Continuous Drain-Source Diode Forward Current	-	-	6.6	A	
$I_{SM}$	Maximum Pulsed Drain-Source Diode Forward Current	-	-	19.8	A	
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}$ , $I_S = 2.8 \text{ A}$	-	-	1.3	V
$trr$	Reverse Recovery Time	$V_R = 400 \text{ V}$ , $I_F = 2.8 \text{ A}$ $dI_F/dt = 100 \text{ A}/\mu\text{s}$	-	170	-	ns
$Qrr$	Reverse Recovery Charge		-	1.1	-	$\mu\text{C}$

**Notes :**

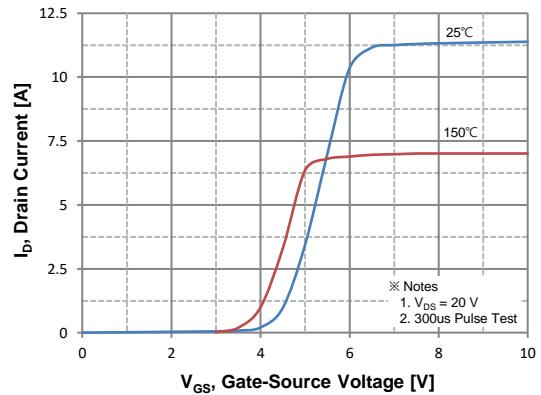
- Repetitive Rating : Pulse width limited by maximum junction temperature
- $I_{AS}=1.4\text{A}$   $V_{DD}=50\text{V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
- Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
- Essentially Independent of Operating Temperature

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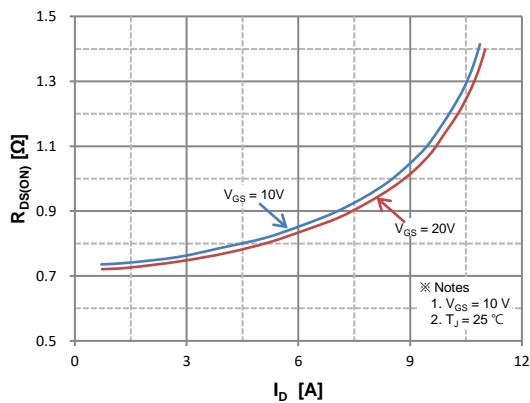
## Typical Characteristics



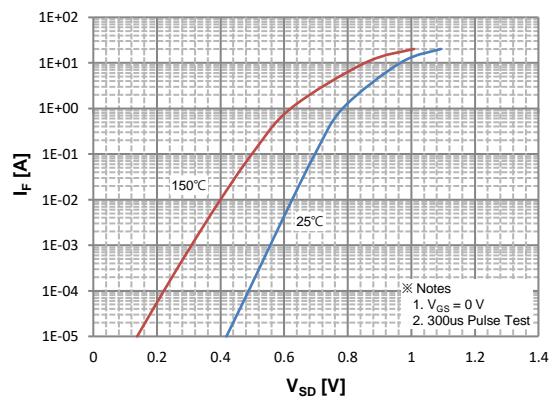
**Figure 1. On Region Characteristics**



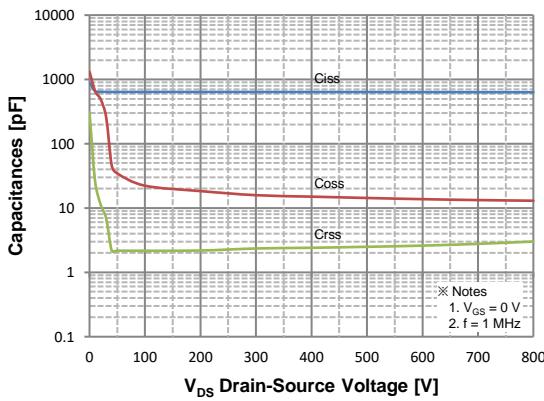
**Figure 2. Transfer Characteristics**



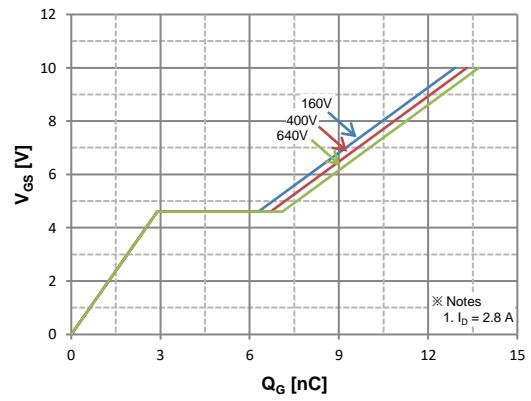
**Figure 3. On Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**



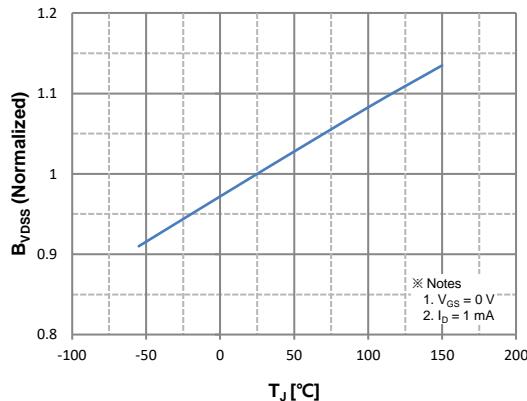
**Figure 5. Capacitance Characteristics**



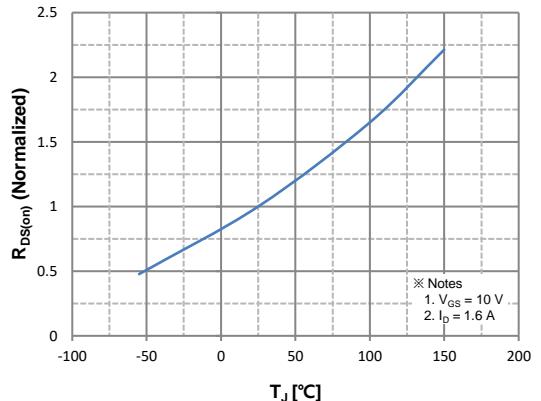
**Figure 6. Gate Charge Characteristics**

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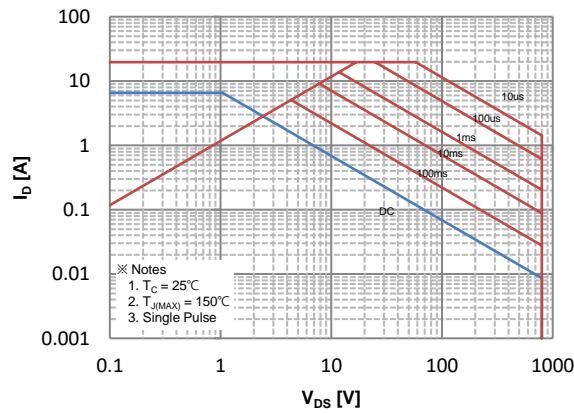
## Typical Characteristics



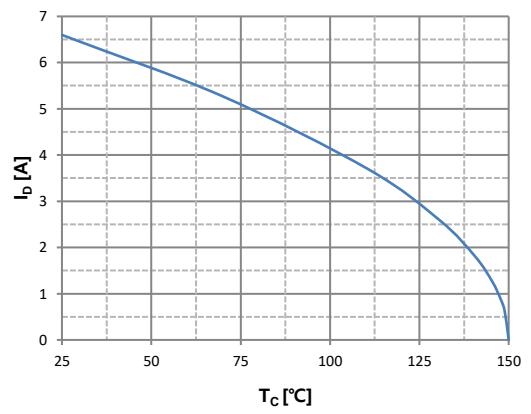
**Figure 7. Breakdown Voltage Variation vs. Temperature**



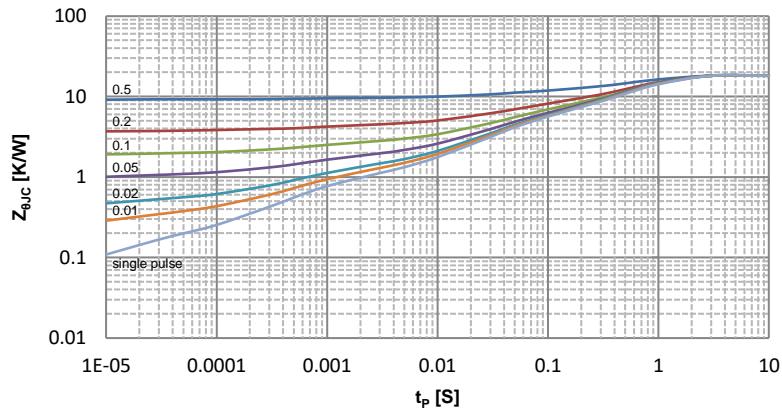
**Figure 8. On-Resistance Variation vs. Temperature**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs. Case Temperature**



**Figure 11. Transient Thermal Response Curve**

Fig 12. Gate Charge Test Circuit & Waveform

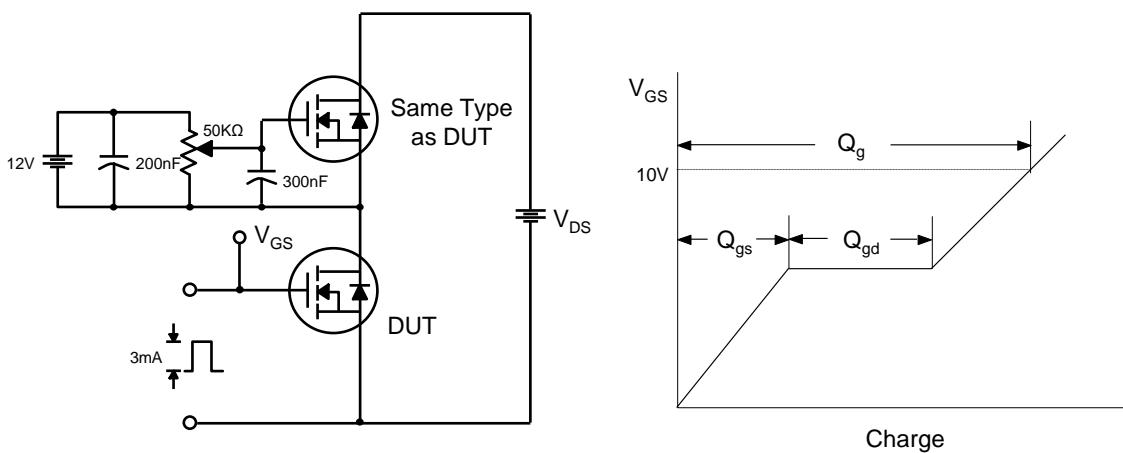


Fig 13. Resistive Switching Test Circuit & Waveforms

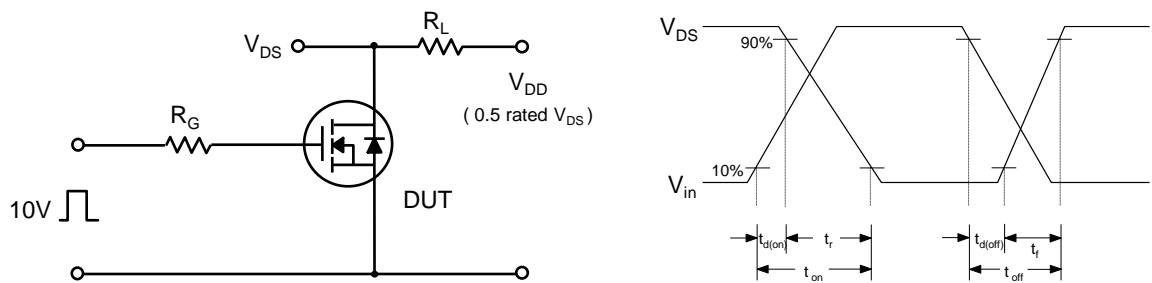


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

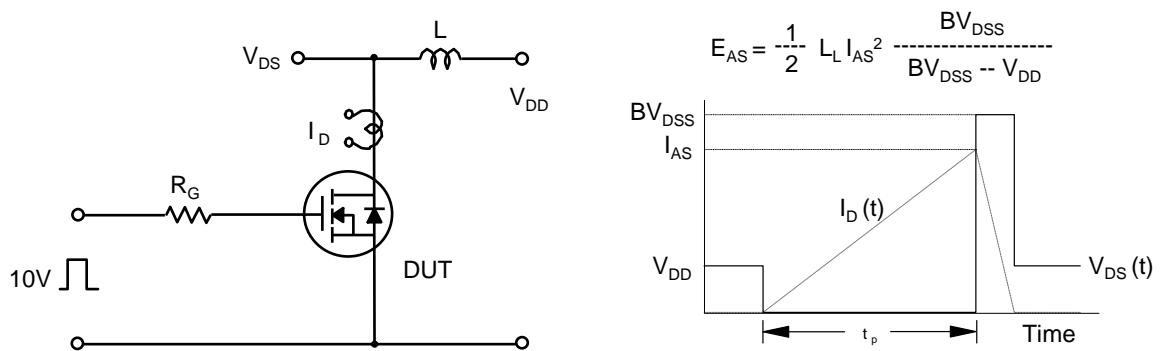
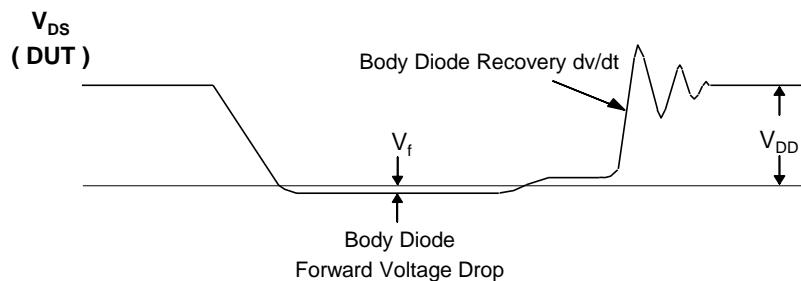
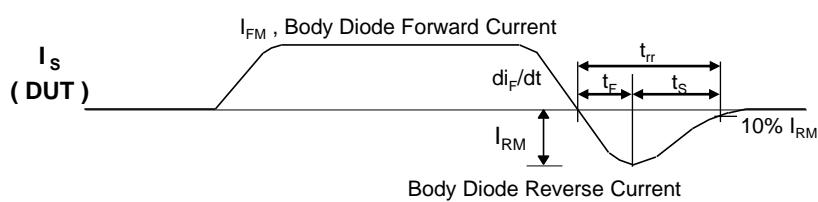
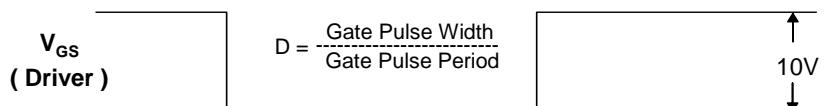
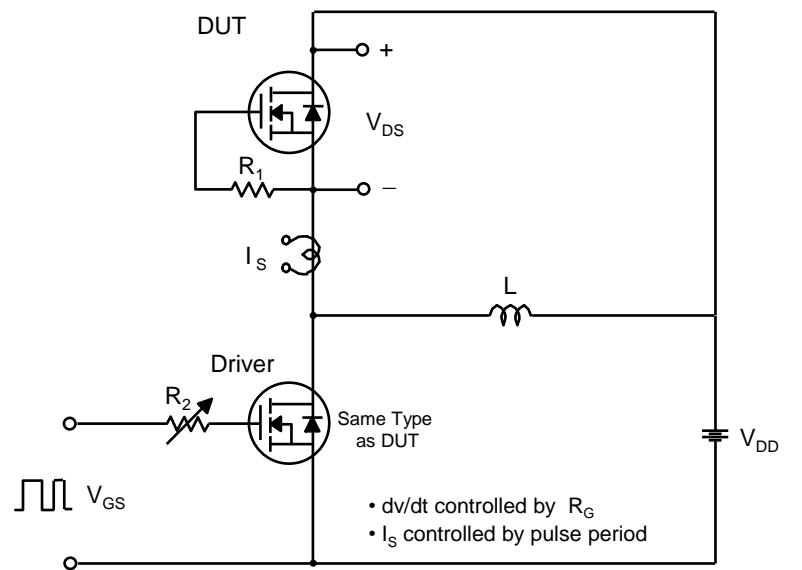
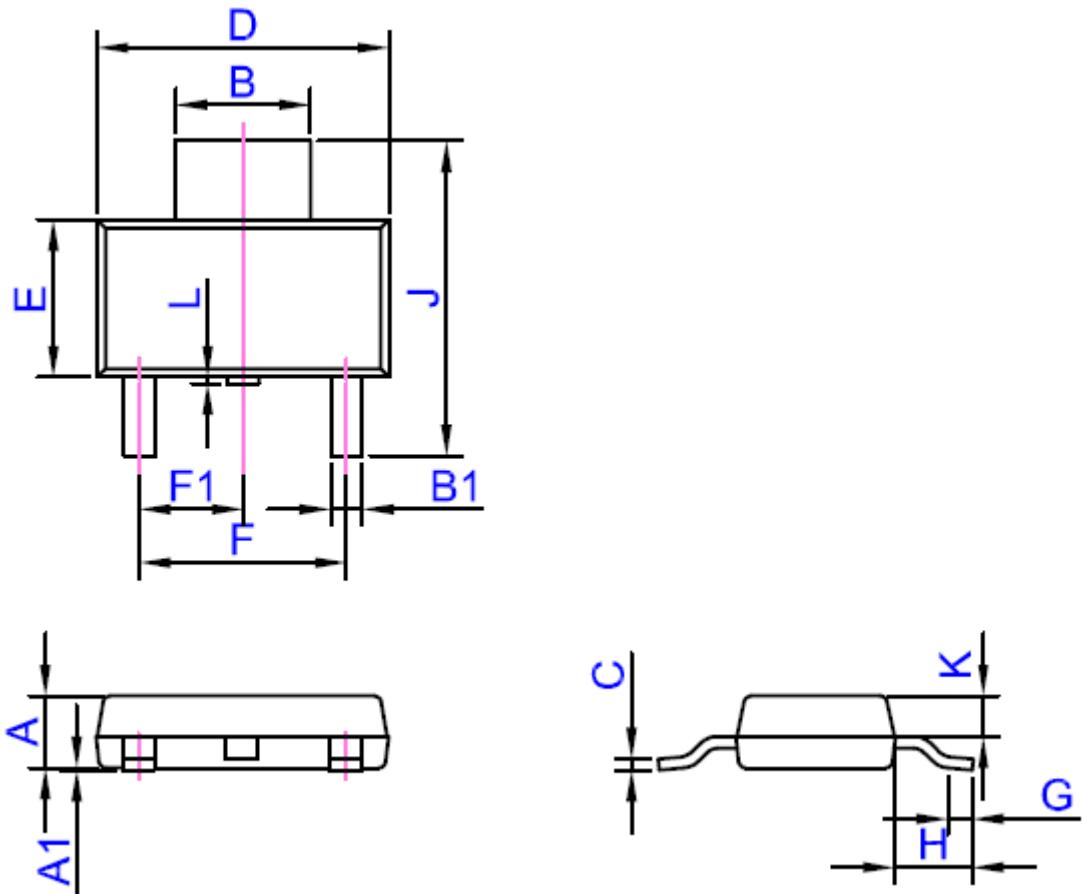


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



### Package Dimension

SOT-223-2L



Ref	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	1.5	1.6	1.8	0.059	0.063	0.071
A1	0.01	0.06	0.10	0.001	0.002	0.004
B	2.9	3.0	3.1	0.114	0.118	0.122
B1	0.6	0.7	0.8	0.024	0.028	0.031
C	0.22	0.254	0.32	0.009	0.010	0.013
D	6.3	6.5	6.7	0.248	0.256	0.264
E	3.3	3.5	3.7	0.130	0.138	0.146
F		4.6			0.181	
F1		2.3			0.091	
G	0.7	0.9	1.1	0.028	0.035	0.043
H	1.5	1.75	2.0	0.059	0.069	0.079
J	6.7	7.0	7.3	0.264	0.276	0.287
K		0.9			0.035	
L	0	0.1	0.2	0	0.004	0.008